Document Number: MRF5S19060N
Rev. 7, 10/2008

RoHS

RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

MRF5S19060NR1
MRF5S19060NBR1

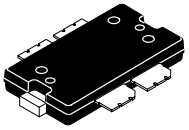
1930-1990 MHz, 12 W AVG., 28 V
2 x N-CDMA
LATERAL N-CHANNEL
RF POWER MOSFETs

Designed for broadband commercial and industrial applications with frequencies from 1930 to 1990 MHz. The high gain and broadband performance of these devices make them ideal for large-signal, common-source amplifier applications in 28 Volt base station equipment.

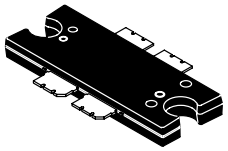
- Typical 2-carrier N-CDMA Performance: V_{DD} = 28 Volts, I_{DQ} = 750 mA, P_{out} = 12 Watts Avg., 1990 MHz, IS-95 (Pilot, Sync, Paging, Traffic Codes 8 Through 13) Channel Bandwidth = 1.2288 MHz. PAR = 9.8 dB @ 0.01% Probability on CCDF.
  - Power Gain — 14 dB
  - Drain Efficiency — 23%
  - IM3 @ 2.5 MHz Offset — -37 dBc in 1.2288 MHz Channel Bandwidth
  - ACPR @ 885 kHz Offset — -51 dBc in 30 kHz Channel Bandwidth
- Capable of Handling 5:1 VSWR, @ 28 Vdc, 1960 MHz, 12 Watts CW Output Power

Features

- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Matched for Ease of Use
- Integrated ESD Protection
- 200°C Capable Plastic Package
- N Suffix Indicates Lead-Free Terminations. RoHS Compliant.
- In Tape and Reel. R1 Suffix = 500 Units per 44 mm, 13 inch Reel.



CASE 1486-03, STYLE 1
TO-270 WB-4
PLASTIC
MRF5S19060NR1



CASE 1484-04, STYLE 1
TO-272 WB-4
PLASTIC
MRF5S19060NBR1

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +65	Vdc
Gate-Source Voltage	V_{GS}	-0.5, +15	Vdc
Total Device Dissipation @ T_C = 25°C Derate above 25°C	P_D	218.8 1.25	W W/°C
Storage Temperature Range	T_{stg}	- 65 to +175	°C
Operating Junction Temperature	T_J	200	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (1,2)	Unit
Thermal Resistance, Junction to Case Case Temperature 75°C, 12 W CW	$R_{\theta JC}$	0.80	°C/W

1. MTTF calculator available at http://www.freescale.com/rf. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers.* Go to http://www.freescale.com/rf. Select Documentation/Application Notes - AN1955.

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Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	1C (Minimum)
Machine Model (per EIA/JESD22-A115)	C (Minimum)
Charge Device Model (per JESD22-C101)	IV (Minimum)

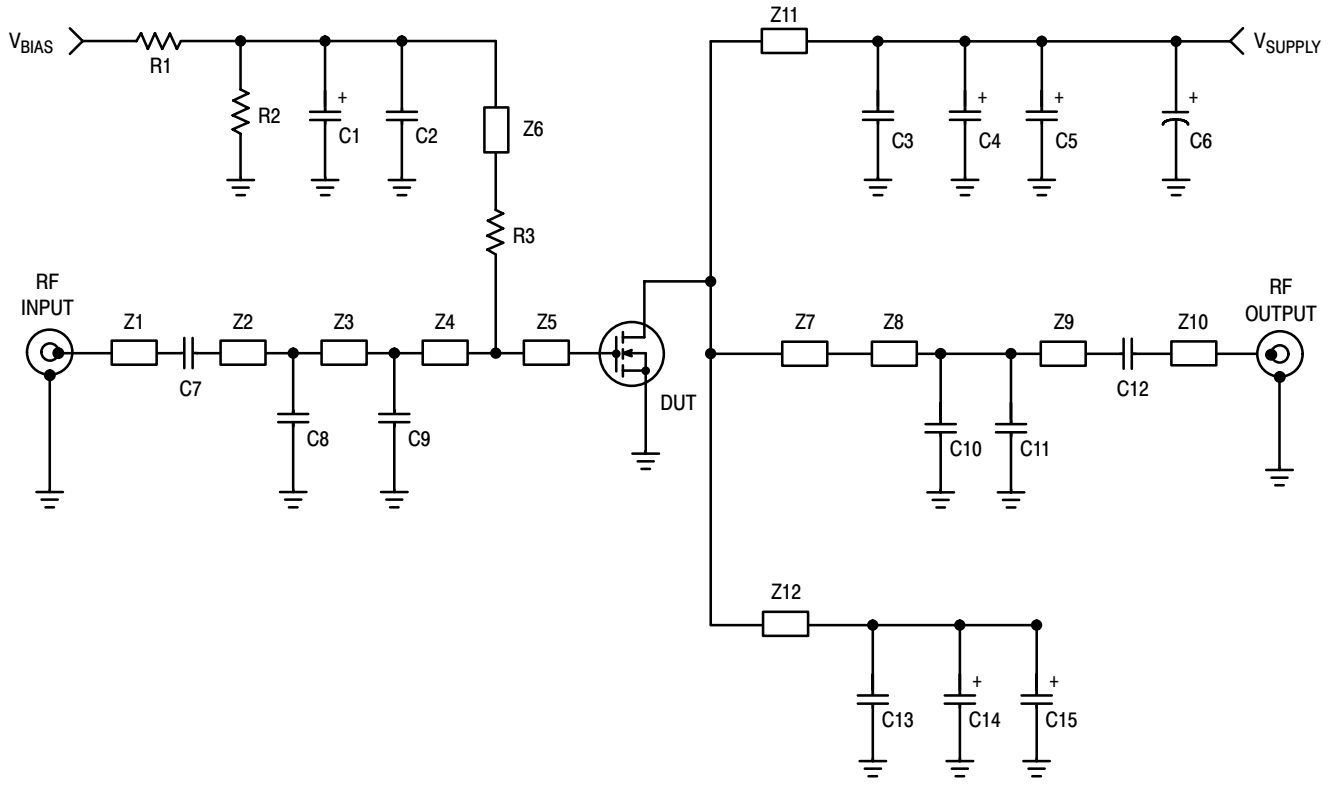
Table 4. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD 22-A113, IPC/JEDEC J-STD-020	3	260	°C

Table 5. Electrical Characteristics (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Off Characteristics					
Zero Gate Voltage Drain Leakage Current (V_{DS} = 65 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current (V_{DS} = 28 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	1	μAdc
Gate-Source Leakage Current (V_{GS} = 5 Vdc, V_{DS} = 0 Vdc)	I_{GSS}	—	—	1	μAdc
On Characteristics					
Gate Threshold Voltage (V_{DS} = 10 Vdc, I_D = 225 μAdc)	$V_{GS(th)}$	2.5	—	3.5	Vdc
Gate Quiescent Voltage (V_{DS} = 28 Vdc, I_D = 750 mAdc)	$V_{GS(Q)}$	—	3.8	—	Vdc
Drain-Source On-Voltage (V_{GS} = 5 Vdc, I_D = 2.25 Adc)	$V_{DS(on)}$	—	0.26	—	Vdc
Forward Transconductance (V_{DS} = 10 Vdc, I_D = 2.25 Adc)	g_{fs}	—	5	—	S
Dynamic Characteristics (1)					
Reverse Transfer Capacitance (V_{DS} = 28 Vdc ± 30 mV(rms)ac @ 1 MHz, V_{GS} = 0 Vdc)	C_{rss}	—	1.5	—	pF
Functional Tests (In Freescale Test Fixture, 50 ohm system) V_{DD} = 28 Vdc, I_{DQ} = 750 mA, P_{out} = 12 W Avg., f1 = 1987.5 MHz, f2 = 1990 MHz, 2-carrier N-CDMA, 1.2288 MHz Channel Bandwidth Carriers. ACPR measured in 30 kHz Channel Bandwidth @ ±885 kHz Offset. IM3 measured in 1.2288 MHz Channel Bandwidth @ ±2.5 MHz Offset. PAR = 9.8 dB @ 0.01% Probability on CCDF.					
Power Gain	G_{ps}	12.5	14	16	dB
Drain Efficiency	η_D	21	23	—	%
Intermodulation Distortion	IM3	—	-37	-35	dBc
Adjacent Channel Power Ratio	ACPR	—	-51	-48	dBc
Input Return Loss	IRL	—	-12	-9	dB
Typical RF Performance (50 ohm system)					
Pulse Peak Power (V_{DD} = 28 Vdc, 1-Tone CW Pulsed, I_{DQ} = 750 mA, t_{ON} = 8 μs, 1% Duty Cycle)	P_{sat}	—	110	—	W
Video Bandwidth (V_{DD} = 28 Vdc, P_{out} = 60 W PEP, I_{DQ} = 750 mA, Tone Spacing = 1 MHz to VBW, Δ IM3<2dB)	VBW	—	35	—	MHz

1. Part is internally matched both on input and output.



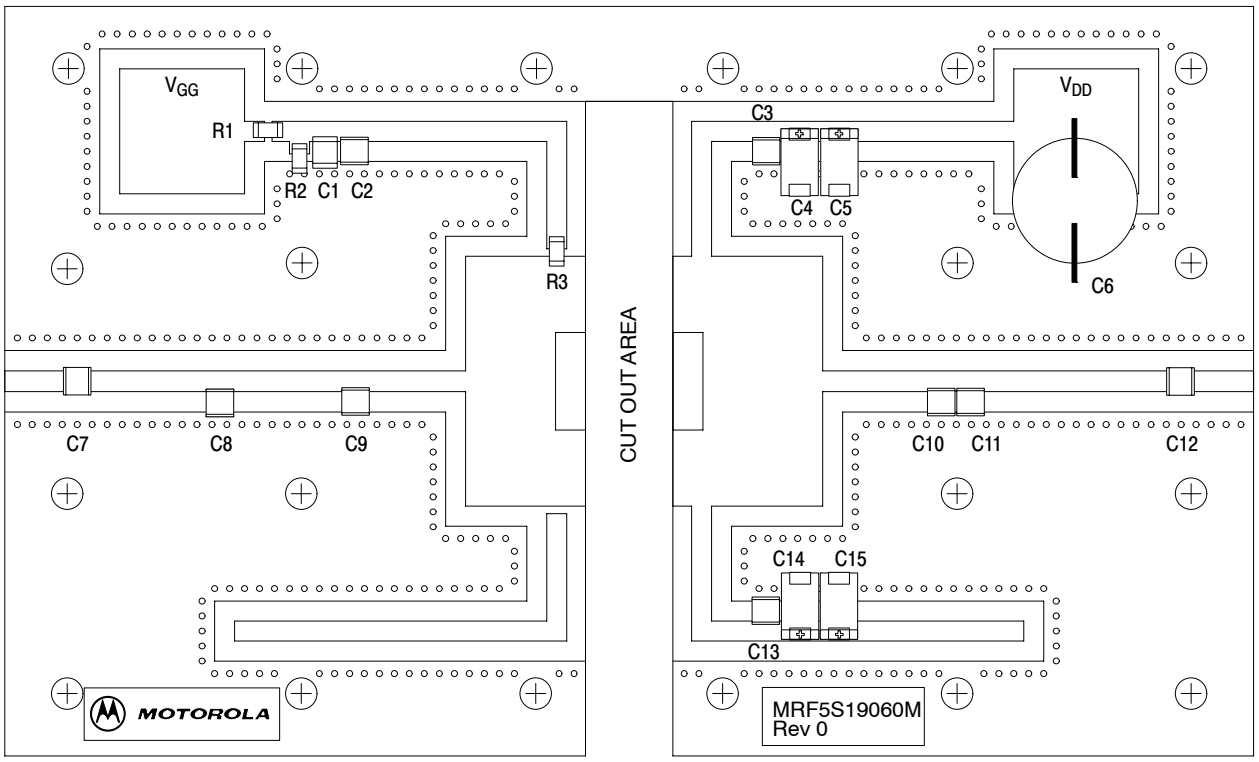
Z1	0.250″ x 0.083″ Microstrip	Z8*	0.420″ x 0.083″ Microstrip
Z2*	0.500″ x 0.083″ Microstrip	Z9*	0.975″ x 0.083″ Microstrip
Z3*	0.500″ x 0.083″ Microstrip	Z10	0.250″ x 0.083″ Microstrip
Z4*	0.515″ x 0.083″ Microstrip	Z11	0.700″ x 0.080″ Microstrip
Z5	0.480″ x 1.000″ Microstrip	Z12	0.700″ x 0.080″ Microstrip
Z6	1.140″ x 0.080″ Microstrip	PCB	Taconic TLX8-0300, 0.030″, ε_r = 2.55
Z7	0.600″ x 1.000″ Microstrip		

* Variable for tuning

Figure 1. MRF5S19060NR1/NBR1 Test Circuit Schematic

Table 6. MRF5S19060NR1/NBR1 Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1	1 μF, 35 V Tantalum Capacitor	TAJB105K35S	AVX
C2	10 pF 100B Chip Capacitor	ATC100B10R0CT500XT	ATC
C3, C7, C12, C13	6.8 pF 100B Chip Capacitors	ATC100B6R8CT500XT	ATC
C4, C5, C14, C15	10 μF, 35 V Tantalum Capacitors	TAJD106K035S	AVX
C6	220 μF, 63 V Electrolytic Capacitor, Radial	2222-136-68221	Vishay
C8	0.8 pF 100B Chip Capacitor	ATC100B0R8BT500XT	ATC
C9	1.5 pF 100B Chip Capacitor	ATC100B1R5BT500XT	ATC
C10	1.0 pF 100B Chip Capacitor	ATC100B1R0BT500XT	ATC
C11	0.2 pF 100B Chip Capacitor	ATC100B0R2BT500XT	ATC
R1, R2	10 kΩ, 1/4 W Chip Resistors	CRCW12061002FKEA	Vishay
R3	10 Ω, 1/4 W Chip Resistors	CRCW120610R0FKEA	Vishay



Freescale has begun the transition of marking Printed Circuit Boards (PCBs) with the Freescale Semiconductor signature/logo. PCBs may have either Motorola or Freescale markings during the transition period. These changes will have no impact on form, fit or function of the current product.

Figure 2. MRF5S19060NR1/NBR1 Test Circuit Component Layout

TYPICAL CHARACTERISTICS

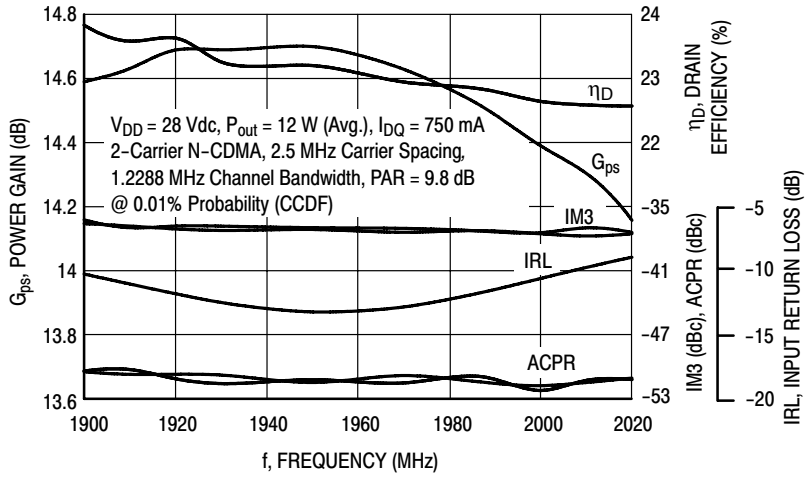


Figure 3. 2-Carrier N-CDMA Broadband Performance @ P_{out} = 12 Watts Avg.

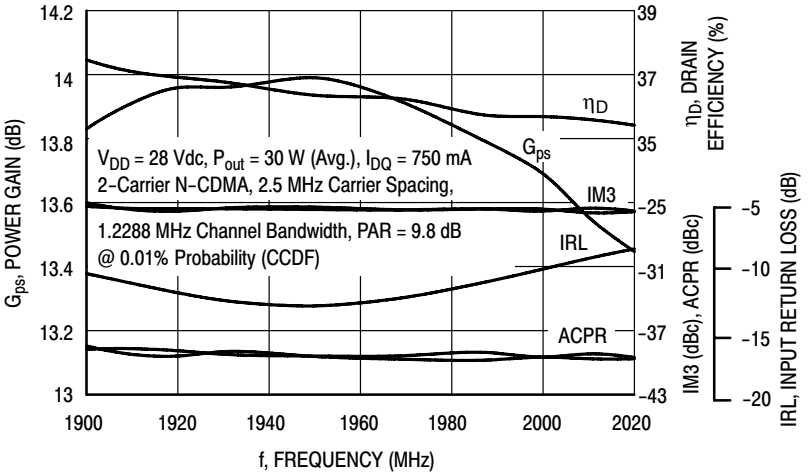


Figure 4. 2-Carrier N-CDMA Broadband Performance @ P_{out} = 30 Watts Avg.

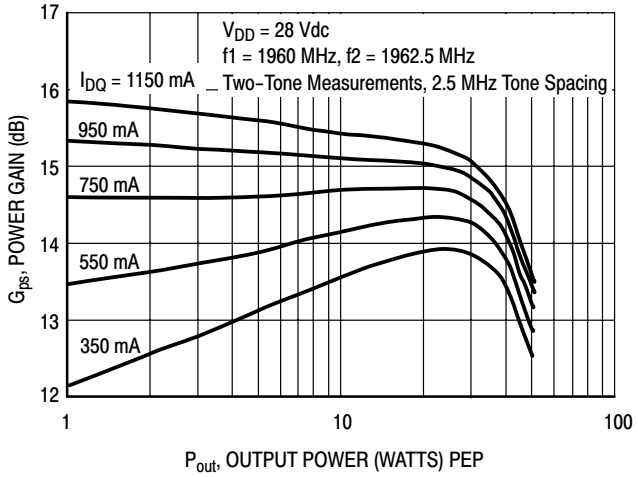


Figure 5. Two-Tone Power Gain versus Output Power

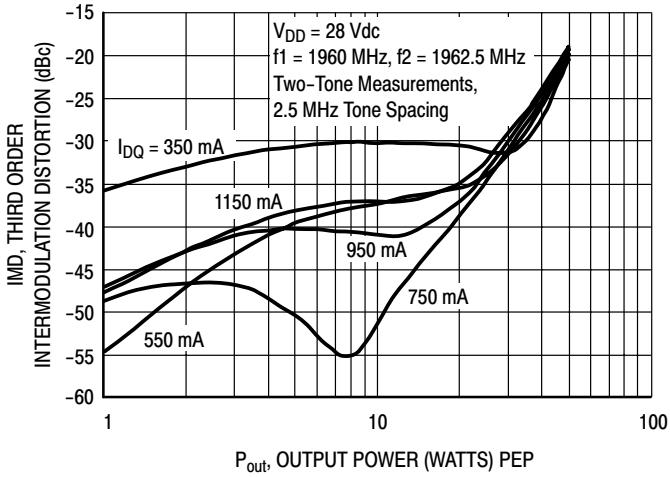


Figure 6. Third Order Intermodulation Distortion versus Output Power

TYPICAL CHARACTERISTICS

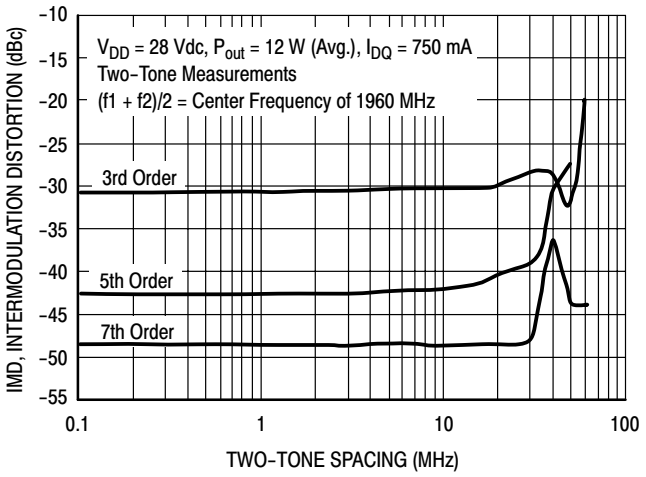


Figure 7. Intermodulation Distortion Products versus Tone Spacing

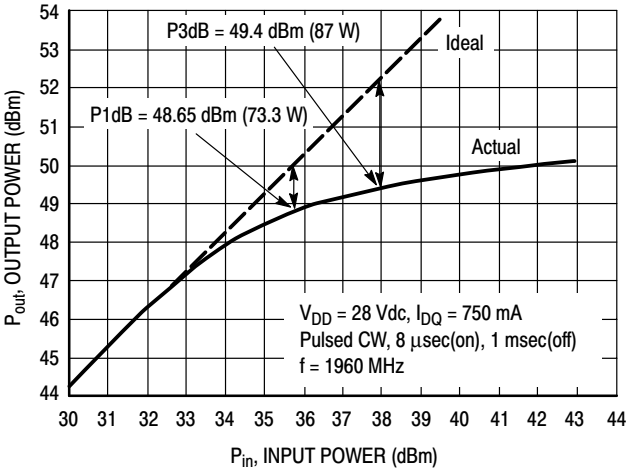


Figure 8. Pulse CW Output Power versus Input Power

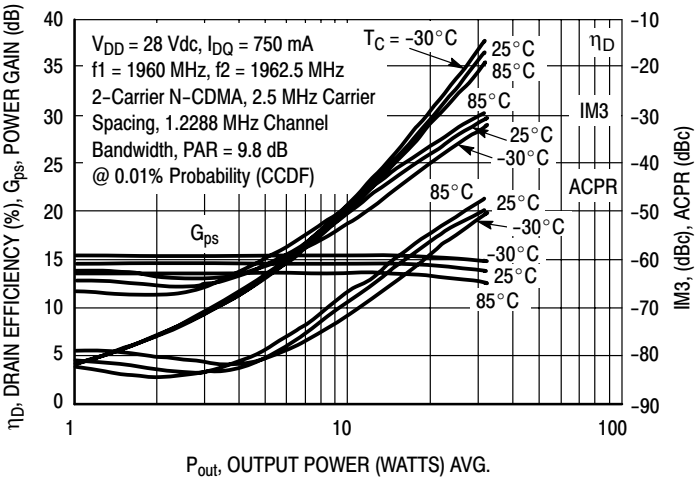


Figure 9. 2-Carrier N-CDMA ACPR, IM3, Power Gain and Drain Efficiency versus Output Power

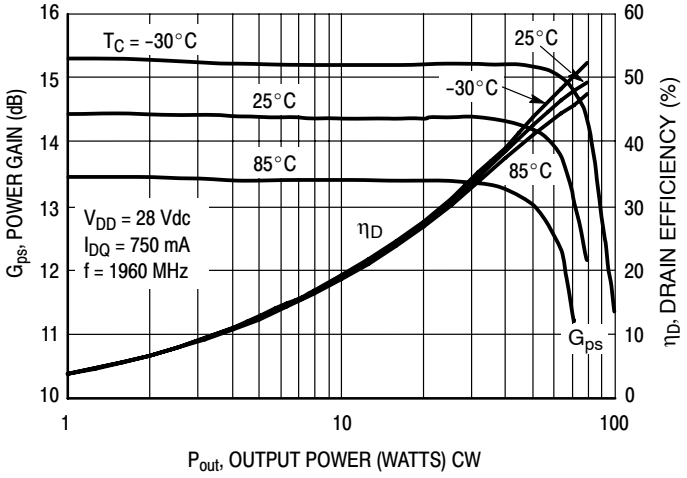


Figure 10. Power Gain and Drain Efficiency versus CW Output Power

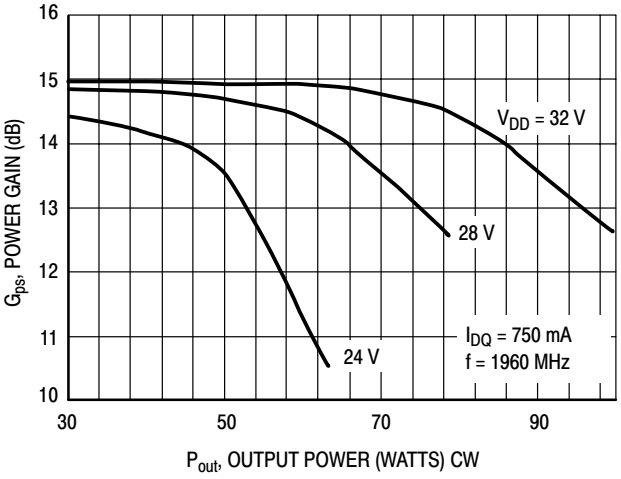
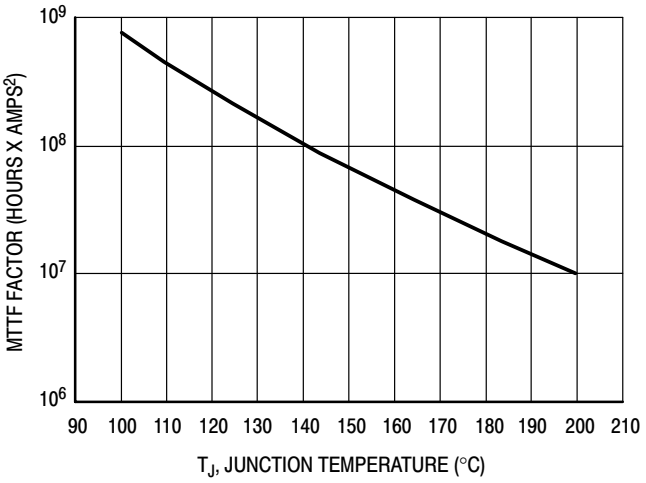


Figure 11. Power Gain versus Output Power

TYPICAL CHARACTERISTICS



This above graph displays calculated MTTF in hours x ampere^2 drain current. Life tests at elevated temperatures have correlated to better than ±10% of the theoretical prediction for metal failure. Divide MTTF factor by I_D^2 for MTTF in a particular application.

Figure 12. MTTF Factor versus Junction Temperature

N-CDMA TEST SIGNAL

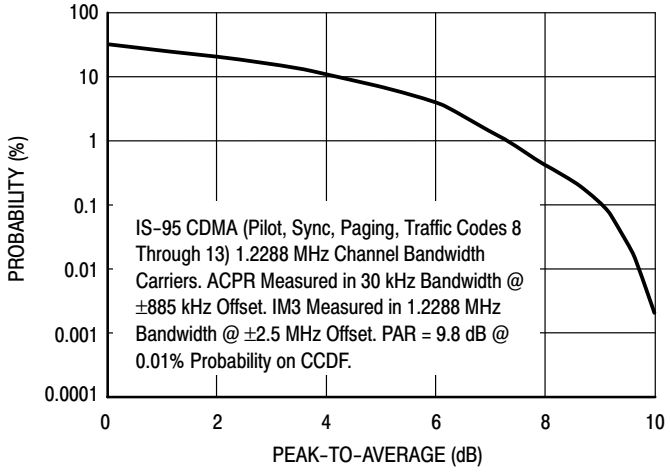


Figure 13. 2-Carrier CCDF N-CDMA

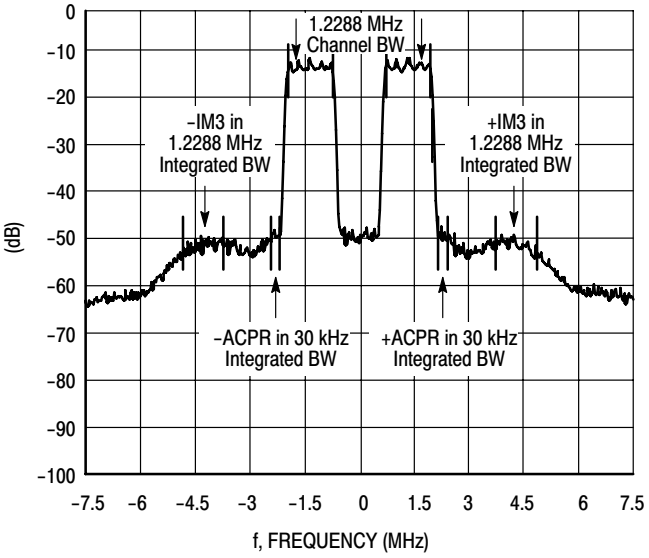
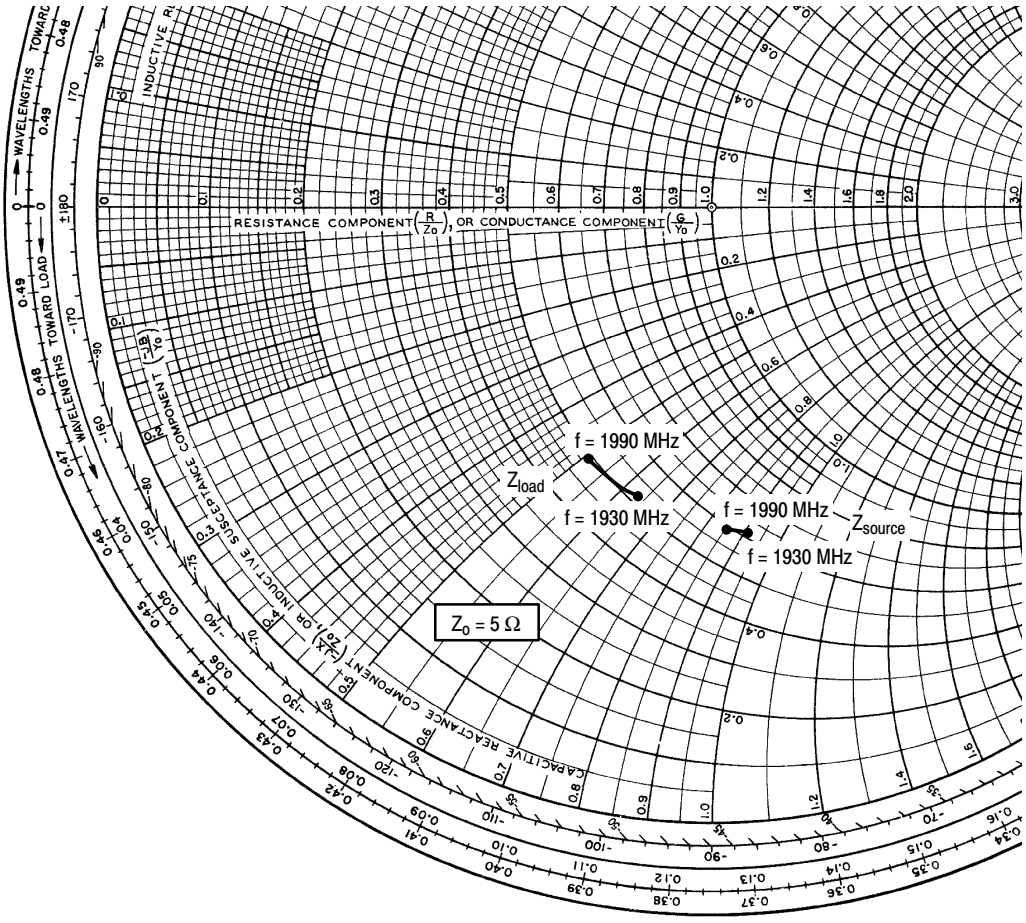


Figure 14. 2-Carrier N-CDMA Spectrum



V_{DD} = 28 Vdc, I_{DQ} = 750 mA, P_{out} = 12 W Avg.

f MHz	Z_{source} Ω	Z_{load} Ω
1930	3.11 - j4.55	2.60 - j3.18
1960	3.06 - j4.38	2.50 - j2.85
1990	2.93 - j4.28	2.44 - j2.53

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

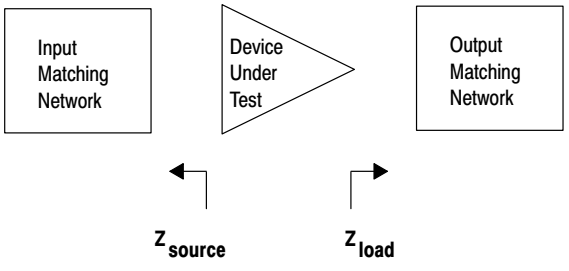
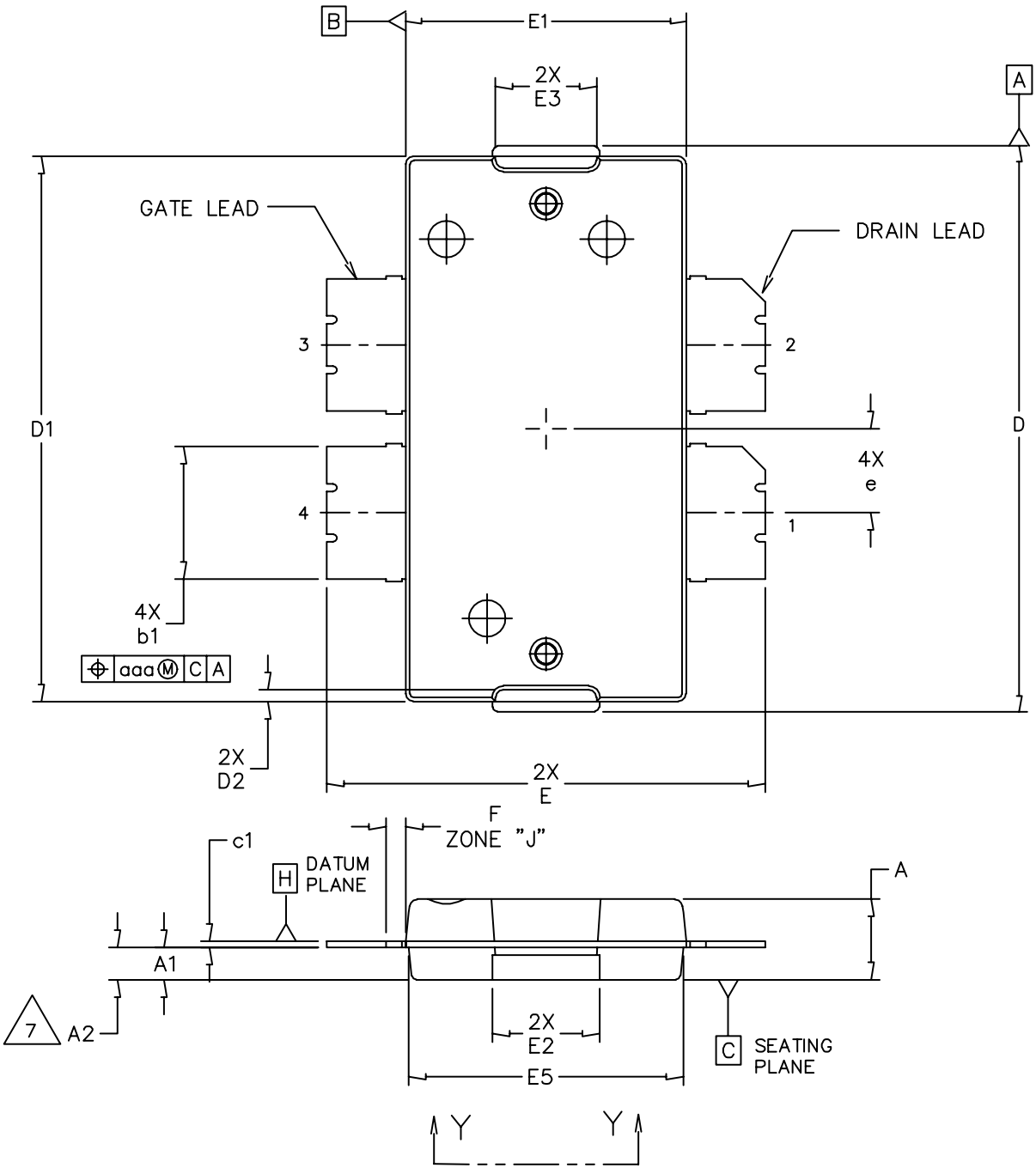
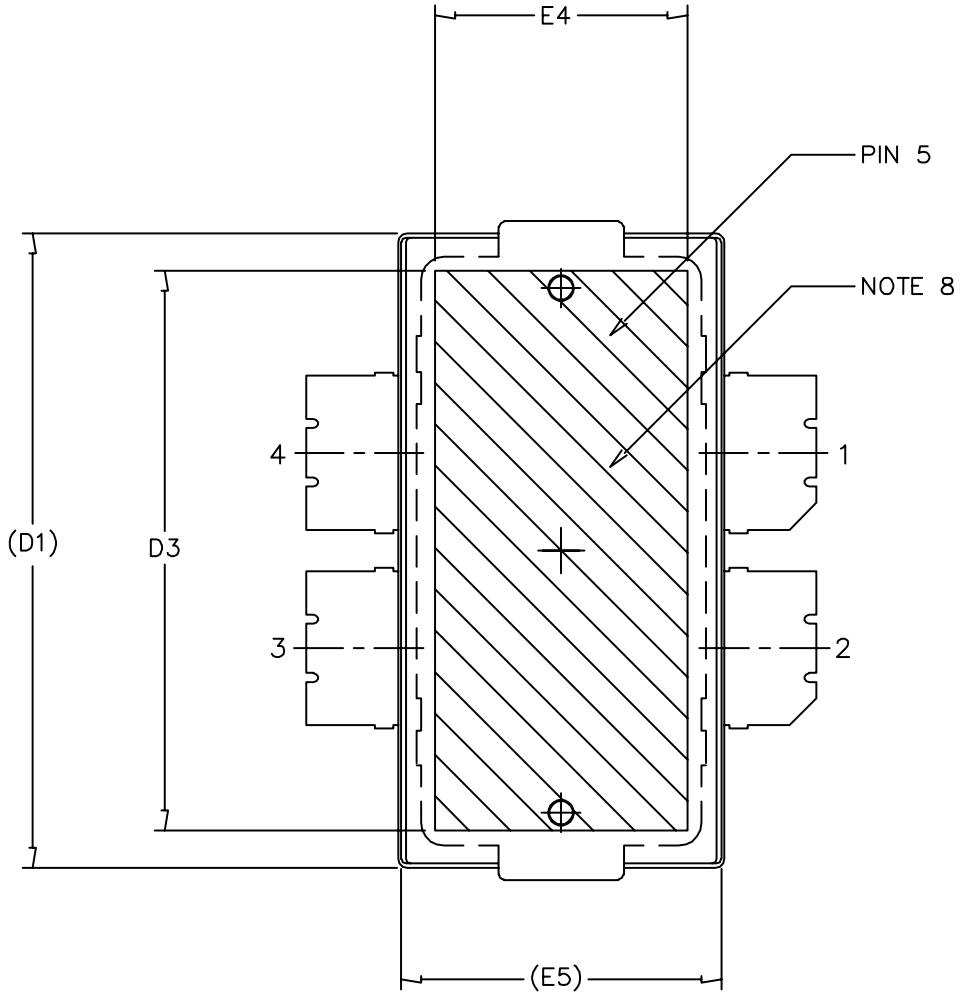


Figure 15. Series Equivalent Source and Load Impedance

PACKAGE DIMENSIONS



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TITLE: TO-270 4 LEAD, WIDE BODY	DOCUMENT NO: 98ASA10577D	REV: D	
	CASE NUMBER: 1486-03	13 AUG 2007	
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	CASE NUMBER: 1486−03	13 AUG 2007
	STANDARD: NON−JEDEC	

NOTES:

1. CONTROLLING DIMENSION: INCH

2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M–1994.

3. DATUM PLANE –H– IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.

4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE –H–.

5. DIMENSIONS "b1" DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE "b1" DIMENSION AT MAXIMUM MATERIAL CONDITION.

6. DATUMS –A– AND –B– TO BE DETERMINED AT DATUM PLANE –H–.

7. DIMENSION A2 APPLIES WITHIN ZONE "J" ONLY.

8. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG.

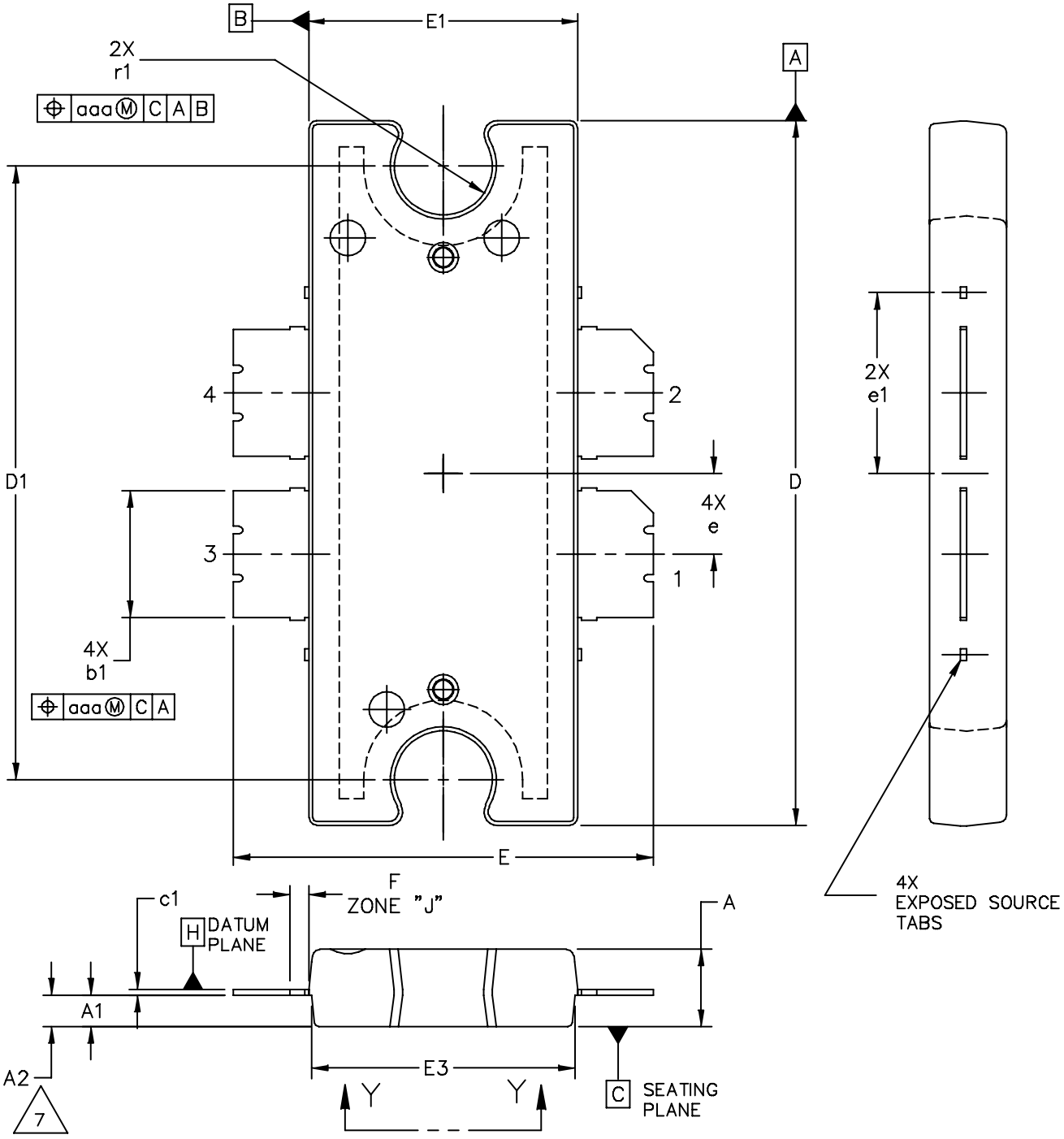
STYLE 1:
PIN 1 – DRAIN PIN 2 – DRAIN
PIN 3 – GATE PIN 4 – GATE
PIN 5 – SOURCE

DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX	DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX
A	.100	.104	2.54	2.64	F	.025 BSC		0.64 BSC	
A1	.039	.043	0.99	1.09	b1	.164	.170	4.17	4.32
A2	.040	.042	1.02	1.07	c1	.007	.011	.18	.28
D	.712	.720	18.08	18.29	e	.106 BSC		2.69 BSC	
D1	.688	.692	17.48	17.58	aaa	.004		.10	
D2	.011	.019	0.28	0.48					
D3	.600	---	15.24	---					
E	.551	.559	14	14.2					
E1	.353	.357	8.97	9.07					
E2	.132	.140	3.35	3.56					
E3	.124	.132	3.15	3.35					
E4	.270	---	6.86	---					
E5	.346	.350	8.79	8.89					

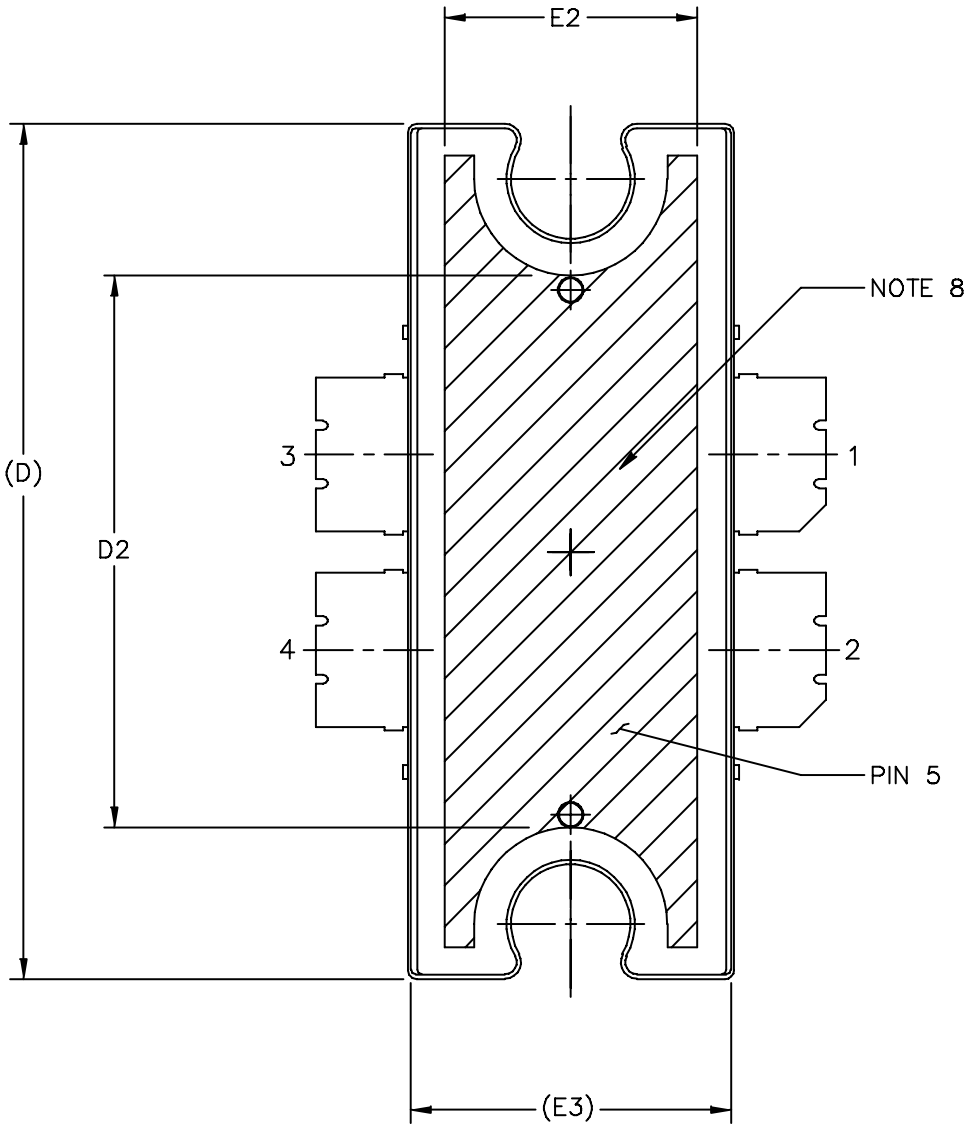
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	CASE NUMBER: 1484−04	31 AUG 2007
	STANDARD: NON−JEDEC	



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	CASE NUMBER: 1484−04	31 AUG 2007
	STANDARD: NON−JEDEC	

NOTES:

1. CONTROLLING DIMENSION: INCH

2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M–1994.

3. DATUM PLANE H IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.

4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.

5. DIMENSIONS "b1" DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE "b1" DIMENSION AT MAXIMUM MATERIAL CONDITION.

6. DATUM A AND B TO BE DETERMINED AT DATUM PLANE H.

7. DIMENSION A2 APPLIES WITHIN ZONE "J" ONLY.

8. HATCHING REPRESENTS EXPOSED AREA OF THE HEAT SLUG. HATCHED AREA SHOWN IS ON THE SAME PLANE.

STYLE 1:
PIN 1 – DRAIN PIN 2 – DRAIN
PIN 3 – GATE PIN 4 – GATE
PIN 5 – SOURCE

DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX	DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX
A	.100	.104	2.54	2.64	b1	.164	.170	4.17	4.32
A1	.039	.043	0.99	1.09	c1	.007	.011	.18	.28
A2	.040	.042	1.02	1.07	r1	.063	.068	1.60	1.73
D	.928	.932	23.57	23.67	e	.106 BSC		2.69 BSC	
D1	.810 BSC		20.57 BSC		e1	.239 INFO ONLY		6.07 INFO ONLY	
D2	.600	---	15.24	---	aaa	.004		.10	
E	.551	.559	14	14.2					
E1	.353	.357	8.97	9.07					
E2	.270	---	6.86	---					
E3	.346	.350	8.79	8.89					
F	.025 BSC		0.64 BSC						

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MECHANICAL OUTLINE | PRINT VERSION NOT TO SCALE

TITLE: TO–272 4 LEAD WIDE BODY

DOCUMENT NO: 98ASA10575D | REV: E

CASE NUMBER: 1484–04 | 31 AUG 2007

STANDARD: NON–JEDEC

PRODUCT DOCUMENTATION

Refer to the following documents to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
7	Oct. 2008	• Modified data sheet to reflect RF Test Reduction described in Product and Process Change Notification number, PCN12779, p. 1, 2 • Updated Part Numbers in Table 6, Component Designations and Values, to RoHS compliant part numbers, p. 3 • Replaced Case Outline 1486-03, Issue C, with 1486-03, Issue D, p. 9-11. Added pin numbers 1 through 4 on Sheet 1. • Replaced Case Outline 1484-04, Issue D, with 1484-04, Issue E, p. 12-14. Added pin numbers 1 through 4 on Sheet 1, replacing Gate and Drain notations with Pin 1 and Pin 2 designations. • Added Product Documentation and Revision History, p. 15

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